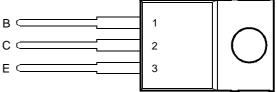
- **Designed for Complementary Use with** BDX34, BDX34A, BDX34B, BDX34C and BDX34D
- 70 W at 25°C Case Temperature
- 10 A Continuous Collector Current
- Minimum h_{FE} of 750 at 3 V, 3 A

TO-220 PACKAGE (TOP VIEW)



Pin 2 is in electrical contact with the mounting base.

MDTRACA

absolute maximum ratings at 25°C case temperature (unless otherwise noted)

RATING	SYMBOL	VALUE	UNIT	
	BDX33		45	
Collector-base voltage (I _E = 0)	BDX33A		60	
	BDX33B	V _{CBO}	80	V
	BDX33C		100	
	BDX33D		120	
	BDX33		45	
Collector-emitter voltage (I _B = 0)	BDX33A		60	
	BDX33B	V _{CEO}	80	V
	BDX33C		100	
	BDX33D		120	
Emitter-base voltage		V _{EBO}	5	V
Continuous collector current	I _C	10	Α	
Continuous base current	I _B	0.3	Α	
Continuous device dissipation at (or below) 25°C case temperature (see Note 1)	P _{tot}	70	W	
Continuous device dissipation at (or below) 25°C free air temperature (see Note	P _{tot}	2	W	
Operating free air temperature range	T _J	-65 to +150	°C	
Storage temperature range	T _{stg}	-65 to +150	°C	
Operating free-air temperature range	T _A	-65 to +150	°C	

NOTES: 1. Derate linearly to 150°C case temperature at the rate of 0.56 W/°C.

2. Derate linearly to 150°C free air temperature at the rate of 16 mW/°C.

BDX33, BDX33A, BDX33B, BDX33C, BDX33D NPN SILICON POWER DARLINGTONS

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electrical characteristics at 25°C case temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS				MIN	TYP	MAX	UNIT
					BDX33	45			 I
V _{(BR)CEO}	Collector-emitter				BDX33A	60			Ī
		$I_{\rm C} = 100 \rm mA$	$I_B = 0$	(see Note 3)	BDX33B	80			V
	breakdown voltage				BDX33C	100			Ī
					BDX33D	120			ı
		V _{CE} = 30 V	$I_B = 0$		BDX33			0.5	mA
		V _{CE} = 30 V	$I_B = 0$		BDX33A			0.5	
		$V_{CE} = 40 \text{ V}$	$I_B = 0$		BDX33B			0.5	
		$V_{CE} = 50 \text{ V}$	$I_B = 0$		BDX33C			0.5	
1	Collector-emitter	$V_{CE} = 60 \text{ V}$	$I_B = 0$		BDX33D			0.5	
I _{CEO}	cut-off current	$V_{CE} = 30 \text{ V}$	$I_B = 0$	$T_C = 100$ °C	BDX33			10	
		$V_{CE} = 30 V$	$I_B = 0$	$T_C = 100$ °C	BDX33A			10	Ī
		$V_{CE} = 40 \text{ V}$	$I_B = 0$	$T_C = 100$ °C	BDX33B			10	Ī
		$V_{CE} = 50 V$	$I_B = 0$	$T_C = 100$ °C	BDX33C			10	
		V _{CE} = 60 V	$I_B = 0$	$T_C = 100$ °C	BDX33D			10	ı
		V _{CB} = 45 V	I _E = 0		BDX33			1	·
		$V_{CB} = 60 \text{ V}$	$I_E = 0$		BDX33A			1	ı
	Collector cut-off	$V_{CB} = 80 \text{ V}$	$I_E = 0$		BDX33B			1	mA
		V _{CB} = 100 V	$I_E = 0$		BDX33C			1	
l		V _{CB} = 120 V	$I_E = 0$		BDX33D			1	
I _{CBO}	current	$V_{CB} = 45 V$	$I_E = 0$	$T_C = 100$ °C	BDX33			5	
		$V_{CB} = 60 \text{ V}$	$I_E = 0$	$T_C = 100$ °C	BDX33A			5	
		$V_{CB} = 80 \text{ V}$	$I_E = 0$	$T_C = 100$ °C	BDX33B			5	
		V _{CB} = 100 V	$I_E = 0$	$T_C = 100$ °C	BDX33C			5	
		V _{CB} = 120 V	$I_E = 0$	T _C = 100°C	BDX33D			5	<u>. </u>
I _{EBO}	Emitter cut-off current	V _{EB} = 5 V	I _C = 0					10	mA
	Forward current transfer ratio	V _{CE} = 3 V	I _C = 4 A		BDX33	750			
		V _{CE} = 3 V	$I_C = 4 A$		BDX33A	750			1
h_{FE}		V _{CE} = 3 V	$I_{C} = 3 A$	(see Notes 3 and 4)	BDX33B	750			Ī
		V _{CE} = 3 V	$I_{C} = 3 A$		BDX33C	750			Ī
		V _{CE} = 3 V	$I_C = 3 A$		BDX33D	750			1
	Base-emitter voltage	V _{CE} = 3 V	I _C = 4 A		BDX33			2.5	·
		V _{CE} = 3 V	$I_C = 4 A$		BDX33A			2.5	Ī
$V_{BE(on)}$		V _{CE} = 3 V	$I_C = 3 A$	(see Notes 3 and 4)	BDX33B			2.5	V
		V _{CE} = 3 V	$I_C = 3 A$		BDX33C			2.5	Ī
		V _{CE} = 3 V	$I_C = 3 A$		BDX33D			2.5	Ī
	Collector-emitter saturation voltage	$I_B = 8 \text{ mA}$	$I_C = 4 A$		BDX33			2.5	i
		$I_B = 8 \text{ mA}$	$I_C = 4 A$		BDX33A			2.5	1
$V_{CE(sat)}$		$I_B = 6 \text{ mA}$	$I_C = 3 A$	(see Notes 3 and 4)	BDX33B			2.5	V
` '		$I_B = 6 \text{ mA}$	$I_C = 3 A$		BDX33C			2.5	
		$I_B = 6 \text{ mA}$	$I_C = 3 A$		BDX33D			2.5	<u></u>
V_{EC}	Parallel diode forward voltage	I _E = 8 A	I _B = 0					4	V

NOTES: 3. These parameters must be measured using pulse techniques, t_p = 300 μ s, duty cycle \leq 2%.

^{4.} These parameters must be measured using voltage-sensing contacts, separate from the current carrying contacts.

BDX33, BDX33A, BDX33B, BDX33C, BDX33D NPN SILICON POWER DARLINGTONS

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thermal characteristics

PARAMETER			TYP	MAX	UNIT
$R_{\theta JC}$	Junction to case thermal resistance			1.78	°C/W
$R_{\theta JA}$	Junction to free air thermal resistance			62.5	°C/W

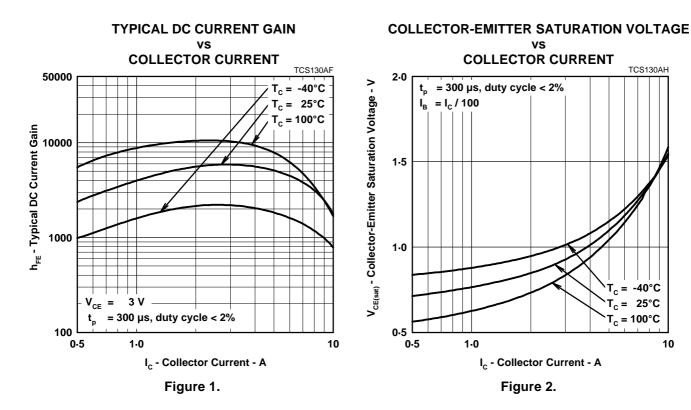
resistive-load-switching characteristics at 25°C case temperature

	PARAMETER	TEST CONDITIONS †			MIN	TYP	MAX	UNIT
t _{on}	Turn-on time	I _C = 3 A	$I_{B(on)} = 12 \text{ mA}$	$I_{B(off)} = -12 \text{ mA}$		1		μs
t _{off}	Turn-off time	$V_{BE(off)} = -3.5 \text{ V}$	$R_L = 10 \Omega$	t_p = 20 μ s, dc \leq 2%		5		μs

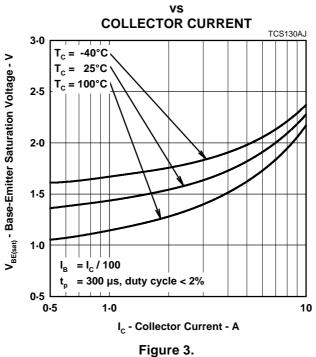
[†] Voltage and current values shown are nominal; exact values vary slightly with transistor parameters.



TYPICAL CHARACTERISTICS



BASE-EMITTER SATURATION VOLTAGE



THERMAL INFORMATION

MAXIMUM POWER DISSIPATION

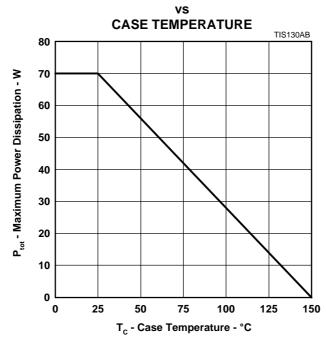


Figure 4.

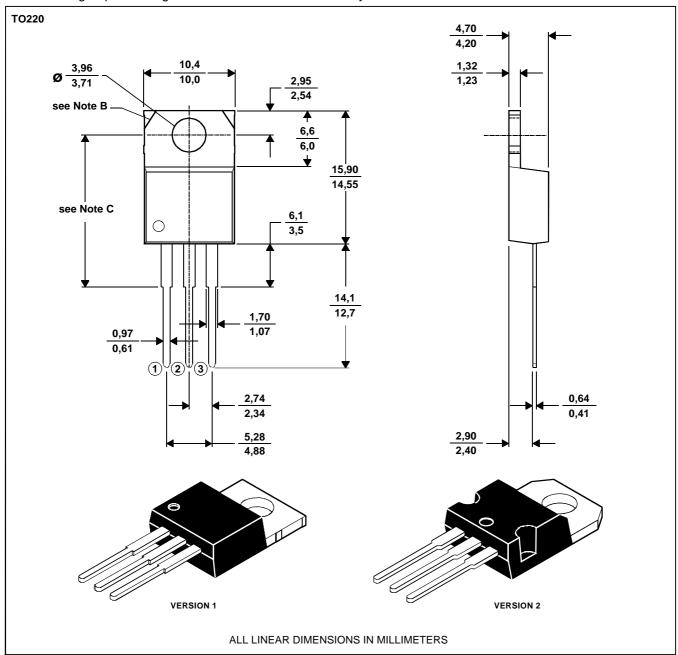
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MECHANICAL DATA

TO-220

3-pin plastic flange-mount package

This single-in-line package consists of a circuit mounted on a lead frame and encapsulated within a plastic compound. The compound will withstand soldering temperature with no deformation, and circuit performance characteristics will remain stable when operated in high humidity conditions. Leads require no additional cleaning or processing when used in soldered assembly.



NOTES: A. The centre pin is in electrical contact with the mounting tab.

- B. Mounting tab corner profile according to package version.
- C. Typical fixing hole centre stand off height according to package version. Version 1, 18.0 mm. Version 2, 17.6 mm.

MDXXBE

PRODUCT INFORMATION

BDX33, BDX33A, BDX33B, BDX33C, BDX33D NPN SILICON POWER DARLINGTONS

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